

Notice of References Cited	Application/Control No. 10/809,960	Applicant(s)/Patent Under Reexamination OLSCHEWSKI ET AL.	
	Examiner Dennis Rosario	Art Unit 2624	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,913,877	07-2005	Chaplen et al.	435/4
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
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	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Donat-P Hader, Image Analysis Methods and Applications, CRC Press, 2nd ed., pp. 409,410.
	V	Bernd Jahne, Spatio-Temporal Image Processing, Springer-Verlag, pp. 86.
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.